

<b>Notice of References Cited</b>	Application/Control No. 10/618,623	Applicant(s)/Patent Under Reexamination ITO ET AL.	
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	B	US-6,150,636	11-2000	Bogdanski et al.	219/461.1
	C	US-4,416,553	11-1983	Huebscher, David A.	374/165
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	L	US-			
	M	US-			

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	N	09-045752	02-1997	JP	Masanao et al	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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